Search Notes

Application/Control I	No. Applicant(s)/Patent und Reexamination	der
10/788,571	SHIH ET AL.	
Examiner	Art Unit	
Edna Wong	1753	

SEARCHED				
Class	Subclass	Date	Examiner	
205	238	12/6/2005	EW	
205	261	12/6/2005	EW	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor Search	12/6/2005	EW	
EAST	12/6/2005	EW	
STN	12/6/2005	EW	
Search Updated	5/15/2006	EW	
		9	